

P-Channel Enhancement-Mode Vertical DMOS FETs

Ordering Information

BV _{DSS} /	R _{DS(ON)}	V _{GS(th)}	I _{D(ON)}	Order Number / Package		kage
BV _{DGS}	(max) (max) (mi		(min)	TO-92	TO-243AA*	Die [†]
-350V	25Ω	-2.4V	-0.4A	TP2535N3	_	_
-400V	25Ω	-2.4V	-0.4A	TP2540N3	TP2540N8	TP2540ND

^{*} Same as SOT-89. Product supplied on 2000 piece carrier tape reels.

Features

- Low threshold -2.4V max.
- High input impedance
- Low input capacitance 125pF max.
- Fast switching speeds
- Low on resistance
- ☐ Free from secondary breakdown
- Low input and output leakage
- Complementary N- and P-channel devices

Applications

- Logic level interfaces ideal for TTL and CMOS
- Solid state relays
- Battery operated systems
- □ Photo voltaic drives
- Analog switches
- General purpose line drivers
- ☐ Telecom switches

Absolute Maximum Ratings

Drain-to-Source Voltage	BV_{DSS}
Drain-to-Gate Voltage	BV _{DGS}
Gate-to-Source Voltage	± 20V
Operating and Storage Temperature	-55°C to +150°C
Soldering Temperature*	300°C

^{*} Distance of 1.6 mm from case for 10 seconds.

Product marking for TO-243AA

TP5D*

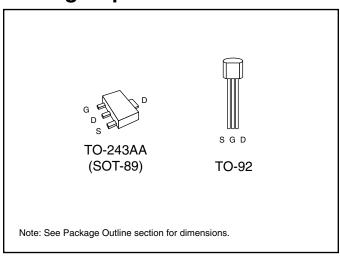
Where * = 2-week alpha date code

Low Threshold DMOS Technology

These low threshold enhancement-mode (normally-off) transistors utilize a vertical DMOS structure and Supertex's well-proven silicon-gate manufacturing process. This combination produces devices with the power handling capabilities of bipolar transistors and with the high input impedance and positive temperature coefficient inherent in MOS devices. Characteristic of all MOS structures, these devices are free from thermal runaway and thermally-induced secondary breakdown.

Supertex's vertical DMOS FETs are ideally suited to a wide range of switching and amplifying applications where very low threshold voltage, high breakdown voltage, high input impedance, low input capacitance, and fast switching speeds are desired.

Package Options



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[†] MIL visual screening available.

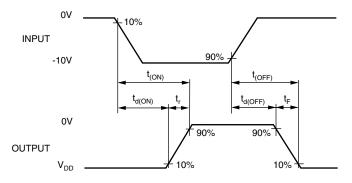
Thermal Characteristics

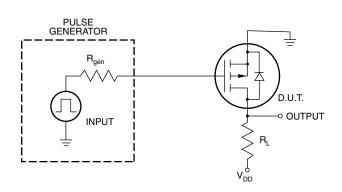
Package	I _D (continuous)*	I _D (pulsed)	Power Dissipation @ T _A = 25°C	θ _{jc} °C/W	θ _{ja} °C/W	I _{DR} *	I _{DRM}
TO-92	-86mA	-0.6A	0.74W	125	170	-86mA	-0.6A
TO-243AA	-125mA	-1.2A	1.6W [†]	15	78 [†]	-125mA	-1.2A

Electrical Characteristics (@ 25°C unless otherwise specified)

Symbol	Parameter		Min	Тур	Max	Unit	Conditions	
BV _{DSS}	Drain-to-Source	TP2540	-400			V	$V_{GS} = 0V$, $I_D = -2mA$	
	Breakdown Voltage	TP2535	-350					
$V_{GS(th)}$	Gate Threshold Voltage	1	-1.0		-2.4	V	$V_{GS} = V_{DS}$, $I_D = -1mA$	
$\Delta V_{GS(th)}$	Change in V _{GS(th)} with Tempera	ture			4.8	mV/°C	$V_{GS} = V_{DS}$, $I_D = -1mA$	
I _{GSS}	Gate Body Leakage				-100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
I _{DSS}	Zero Gate Voltage Drain Current				-10	μΑ	V _{GS} = 0V, V _{DS} = Max Rating	
					-1.0	mA	$V_{GS} = 0V$, $V_{DS} = 0.8$ Max Rating $T_A = 125$ °C	
I _{D(ON)}	ON-State Drain Current		-0.2	-0.3		A	$V_{GS} = -4.5V, V_{DS} = -25V$	
			-0.4	-1.1		^	$V_{GS} = -10V, V_{DS} = -25V$	
R _{DS(ON)}	Static Drain-to-Source			20	30	Ω	$V_{GS} = -4.5V, I_{D} = -100mA$	
	ON-State Resistance			19	25		$V_{GS} = -10V, I_D = -100mA$	
$\Delta R_{DS(ON)}$	Change in R _{DS(ON)} with Temperature				0.75	%/°C	$V_{GS} = -10V, I_D = -100mA$	
G _{FS}	Forward Transconductance		100	175		mʊ	$V_{DS} = -25V, I_{D} = -100mA$	
C _{ISS}	Input Capacitance			60	125	pF	V _{GS} = 0V, V _{DS} = -25V f = 1 MHz	
C _{oss}	Common Source Output Capacitance			20	70			
C _{RSS}	Reverse Transfer Capacitance			10	25		1 - 1 111112	
t _{d(ON)}	Turn-ON Delay Time				10	ns	$V_{DD} = -25V$ $I_{D} = -0.4A$ $R_{GFN} = 25\Omega$	
t _r	Rise Time				10			
t _{d(OFF)}	Turn-OFF Delay Time				20			
t _f	Fall Time				13		32	
V _{SD}	Diode Forward Voltage Drop				-1.8	V	V _{GS} = 0V, I _{SD} = -100mA	
t _{rr}	Reverse Recovery Time			300		ns	$V_{GS} = 0V, I_{SD} = -100mA$	

Switching Waveforms and Test Circuit





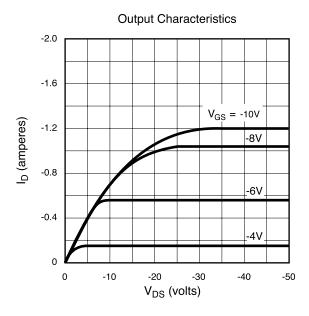
^{*} I_D (continuous) is limited by max rated T_j.

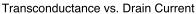
† Mounted on FR5 Board, 25mm x 25mm x 1.57mm. Signficant P_D increase possible on ceramic substrate.

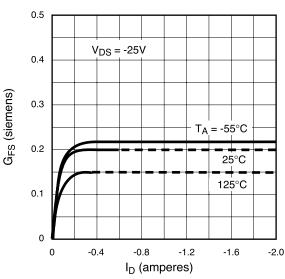
^{1.} All D.C. parameters 100% tested at 25°C unless otherwise stated. (Pulse test: $300\mu s$ pulse, 2% duty cycle.)

^{2.} All A.C. parameters sample tested.

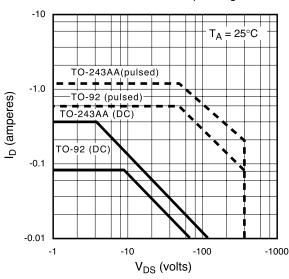
Typical Performance Curves



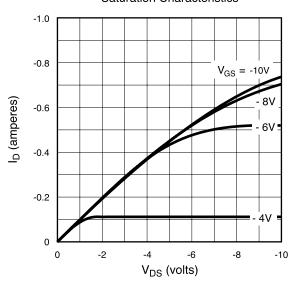




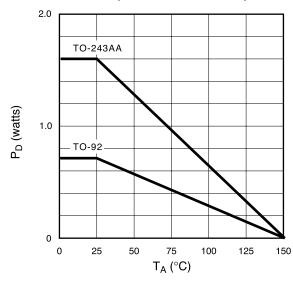
Maximum Rated Safe Operating Area



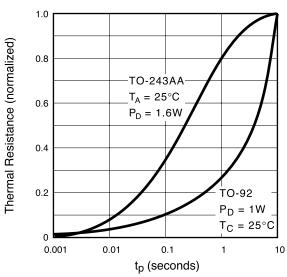
Saturation Characteristics



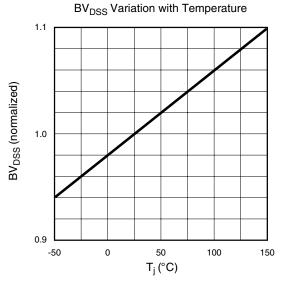
Power Dissipation vs. Ambient Temperature

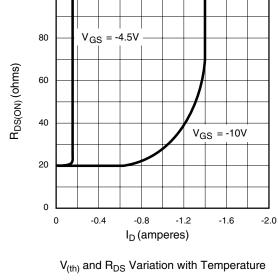


Thermal Response Characteristics



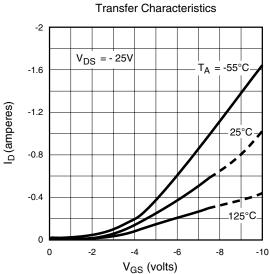
Typical Performance Curves

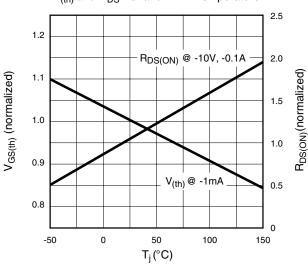


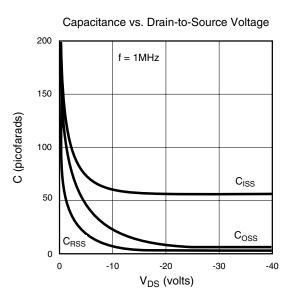


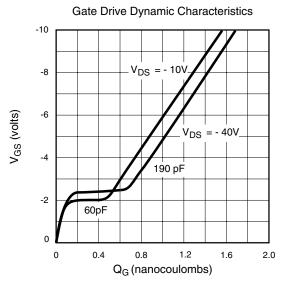
On-Resistance vs. Drain Current

100









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